

<b>Notice of References Cited</b>	Application/Control No. 09/489,668	Applicant(s)/Patent Under Reexamination DABAK ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0000948 A1	01-2002	Chun et al.	343/853
	B	US-2002/0034263 A1	03-2002	Schmidl et al.	375/299
	C	US-6,714,514 B1	03-2004	Espax et al.	370/230
	D	US-5,307,371 A	04-1994	Juola, Veli	375/133
	E	US-5,327,143 A	07-1994	Goetz et al.	342/382
	F	US-5,428,602 A	06-1995	Kemppainen, Jari	370/330
	G	US-6,728,517 B2	04-2004	Sugar et al.	455/73
	H	US-6,717,516 B2	04-2004	Bridgelall, Raj	340/572.1
	I	US-2004/0162037 A1	08-2004	Shpak, Eran	455/101
	J	US-2002/0183013 A1	12-2002	Auckland et al.	455/73
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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